



PTO/SB/08a/b (07-05)

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>			Complete if Known		
			Application Number	10/733,807-Conf. #8859	
			Filing Date	December 11, 2003	
			First Named Inventor	Paul R. McHugh	
			Art Unit	1742	
			Examiner Name	W. T. Leader Zheng	
Sheet	1	of	2	Attorney Docket Number	291958241US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
LZ		US-60/476,786		Davis et al.	
LZ		US-60/476,881		Hanson	
LZ		US-60/484,603		Wilson et al.	
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NON PATENT LITERATURE DOCUMENTS			
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LZ		WU, Z.L. et al., "Methods for Characterization of Mass Transfer Boundary layer in an industrial Semiconductor Wafer Plating Cell," Abs. 165, 205 th Meeting, © The Electrochemical Society, Inc., 2004 (1 Page).	

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LZ		TACKEN, R.A. et al., "Applications of Magnetoelectrolysis", Journal of Applied Electrochemistry, 1995 (no month), Vol. 25, pages 1-5		
LZ		International Search Report for PCT/USO4/17670; Mailed June 22, 2006; Applicant: Semitool, Inc. (19 pages)		

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